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| Notice of References Cited | Application/Control No. 10/806,087 | Applicant(s)/Patent Under Reexamination RAJENDRAN ET AL. | |
| | Examiner William H. Rodriguez | Art Unit 3746 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-4,818,198 A | 04-1989 | Tamura et al. | 418/55.6 |
| * | B | US-4,946,361 A | 08-1990 | DeBlois et al. | 418/55.6 |
| * | C | US-5,211,031 A | 05-1993 | Murayama et al. | 62/498 |
| * | D | US-5,328,344 A | 07-1994 | Sato et al. | 418/85 |
| * | E | US-5,931,649 A | 08-1999 | Caillat et al. | 418/55.1 |
| * | F | US-6,027,321 A | 02-2000 | Shim et al. | 418/1 |
| * | G | US-6,264,446 B1 | 07-2001 | Rajendran et al. | 418/55.6 |
| * | H | US-6,280,154 B1 | 08-2001 | Clendenin et al. | 417/410.5 |
| * | I | US-6,290,472 B1 | 09-2001 | Gannaway, Edwin L. | 417/371 |
| * | J | US-6,322,339 B1 | 11-2001 | Mitsunaga et al. | 418/55.2 |
| * | K | US-6,929,455 B2 | 08-2005 | Dreiman et al. | 417/410.3 |
| * | L | US-6,988,876 B2 | 01-2006 | Ke et al. | 418/60 |
| * | M | US-7,094,043 B2 | 08-2006 | Skinner, Robin G | 418/55.6 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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